

8-Bit Register

Features

- Function, pinout and drive compatible with FCT and F logic
- FCT-C speed at 5.2 ns max. (Com'l)
FCT-A speed at 7.2 ns max. (Com'l)
- Reduced V_{OH} (typically = 3.3V) versions of equivalent FCT functions
- Edge-rate control circuitry for significantly improved noise characteristics
- Power-off disable feature
- Matched rise and fall times
- ESD > 2000V

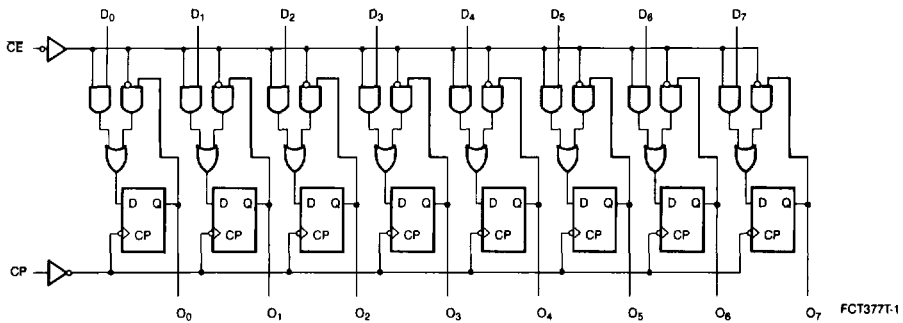
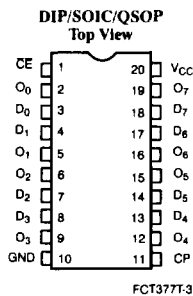
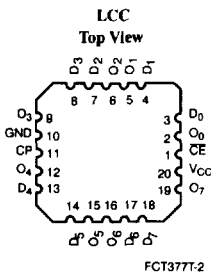
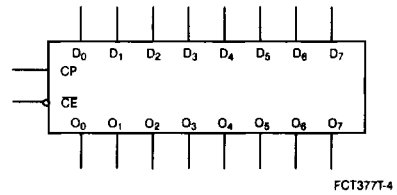
- Fully compatible with TTL input and output logic levels
- Sink current 64 mA (Com'l),
 32 mA (Mil)
- Source current 32 mA (Com'l),
 12 mA (Mil)
- Clock Enable for address and data synchronization application
- Eight edge-triggered D flip-flops

Functional Description

The FCT377T has eight triggered D-type flip-flops with individual D inputs. The common buffered clock inputs (CP) loads

all flip-flops simultaneously when the Clock Enable (CE) is LOW. The register is fully edge-triggered. The state of each D input, one set-up time before the LOW-to-HIGH clock transition, is transferred to the corresponding flip-flop's O output. The CE input must be stable only one set-up time prior to the LOW-to-HIGH clock transition for predictable operation.

The outputs are designed with a power-off disable feature to allow for live insertion of boards.

Logic Block Diagram

Pin Configurations

Logic Symbol


Function Table^[1]

| Operating Mode | Inputs | | | Outputs |
|----------------|--------|----|---|-----------|
| | CP | CE | D | O |
| Load "1" | ┐ | l | h | H |
| Load "0" | ┐ | l | l | L |
| Hold | ┐ | h | X | No Change |
| | X | H | X | No Change |

Maximum Ratings^[2,3]

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature -65°C to +150°C
 Ambient Temperature with Power Applied -65°C to +135°C
 Supply Voltage to Ground Potential -0.5V to +7.0V
 DC Input Voltage -0.5V to +7.0V
 DC Output Voltage -0.5V to +7.0V
 DC Output Current (Maximum Sink Current/Pin) 120 mA
 Power Dissipation 0.5W

Static Discharge Voltage >2001V
 (per MIL-STD-883, Method 3015)

Operating Range

| Range | Range | Ambient Temperature | V _{CC} |
|-------------------------|-------|---------------------|-----------------|
| Commercial | CT | 0°C to +70°C | 5V ± 5% |
| Commercial | T, AT | -40°C to +85°C | 5V ± 5% |
| Military ^[4] | All | -55°C to +125°C | 5V ± 10% |

Electrical Characteristics Over the Operating Range

| Parameter | Description | Test Conditions | | Min. | Typ. ^[5] | Max. | Unit |
|------------------|---------------------------------------------|---------------------------------------------------------|-------|------|---------------------|------|------|
| V _{OH} | Output HIGH Voltage | V _{CC} =Min., I _{OH} =-32 mA | Com'l | 2.0 | | | V |
| | | V _{CC} =Min., I _{OH} =-15 mA | Com'l | 2.4 | 3.3 | | V |
| | | V _{CC} =Min., I _{OH} =-12 mA | Mil | 2.4 | 3.3 | | V |
| V _{OL} | Output LOW Voltage | V _{CC} =Min., I _{OL} =64 mA | Com'l | | 0.3 | 0.55 | V |
| | | V _{CC} =Min., I _{OL} =32 mA | Mil | | 0.3 | 0.55 | V |
| V _{IH} | Input HIGH Voltage | | | 2.0 | | | V |
| V _{IL} | Input LOW Voltage | | | | | 0.8 | V |
| V _H | Hysteresis ^[6] | All inputs | | | 0.2 | | V |
| V _{IK} | Input Clamp Diode Voltage | V _{CC} =Min., I _{IN} =-18 mA | | | -0.7 | -1.2 | V |
| I _I | Input HIGH Current | V _{CC} =Max., V _{IN} =V _{CC} | | | | 5 | μA |
| I _{IH} | Input HIGH Current | V _{CC} =Max., V _{IN} =2.7V | | | | ±1 | μA |
| I _{IL} | Input LOW Current | V _{CC} =Max., V _{IN} =0.5V | | | | ±1 | μA |
| I _{OS} | Output Short Circuit Current ^[7] | V _{CC} =Max., V _{OUT} =0.0V | | -60 | -120 | -225 | mA |
| I _{OFF} | Power-Off Disable | V _{CC} =0V, V _{OUT} =4.5V | | | | ±1 | μA |

Notes:

- H = HIGH Voltage Level
 h = HIGH Voltage Level one set-up time prior to the LOW-to-HIGH Clock Transition
 L = LOW Voltage Level
 l = LOW Voltage Level one set-up time prior to the LOW-to-HIGH Clock Transition
 X = Don't Care
 Z = HIGH Impedance
 ┐ = LOW-to-HIGH clock transition
- Unless otherwise noted, these limits are over the operating free-air temperature range.
- Unused inputs must always be connected to an appropriate logic voltage level, preferably either V_{CC} or ground.

- T_A is the "instant on" case temperature.
- Typical values are at V_{CC}=5.0V, T_A=+25°C ambient.
- This parameter is guaranteed but not tested.
- Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample and hold techniques are preferable in order to minimize internal chip heating and more accurately reflect operational values. Otherwise prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parametric tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

Capacitance^[6]

| Parameter | Description | Typ. ^[5] | Max. | Unit |
|------------------|--------------------|---------------------|------|------|
| C _{IN} | Input Capacitance | 5 | 10 | pF |
| C _{OUT} | Output Capacitance | 9 | 12 | pF |

Power Supply Characteristics

| Parameter | Description | Test Conditions | Typ. ^[5] | Max. | Unit |
|------------------|--------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------|----------------------|------------|
| I _{CC} | Quiescent Power Supply Current | V _{CC} =Max., V _{IN} ≤0.2V, V _{IN} ≥V _{CC} -0.2V | 0.1 | 0.2 | mA |
| ΔI _{CC} | Quiescent Power Supply Current (TTL inputs HIGH) | V _{CC} =Max., V _{IN} =3.4V, ^[8] f ₁ =0, Outputs Open | 0.5 | 2.0 | mA |
| I _{CCD} | Dynamic Power Supply Current ^[9] | V _{CC} =Max., One Bit Toggling, 50% Duty Cycle, Outputs Open, CE=GND, V _{IN} ≤0.2V or V _{IN} ≥V _{CC} -0.2V | 0.06 | 0.12 | mA/ MHz |
| I _C | Total Power Supply Current ^[10] | V _{CC} =Max., f ₀ =10 MHz, 50% Duty Cycle, Outputs Open, One Bit Toggling at f ₁ =5 MHz, CE=GND, V _{IN} ≤0.2V or V _{IN} ≥V _{CC} -0.2V | 0.7 | 1.4 | mA |
| | | V _{CC} =Max., f ₀ =10 MHz, 50% Duty Cycle, Outputs Open, One Bit Toggling at f ₁ =5 MHz, CE=GND, V _{IN} =3.4V or V _{IN} =GND | 1.2 | 3.4 | mA |
| | | V _{CC} =Max., f ₀ =10 MHz, 50% Duty Cycle, Outputs Open, Eight Bits Toggling at f ₁ =2.5 MHz, CE=GND, V _{IN} ≤0.2V or V _{IN} ≥V _{CC} -0.2V | 1.6 | 3.2 ^[11] | mA |
| | | V _{CC} =Max., f ₀ =10 MHz, 50% Duty Cycle, Outputs Open, Eight Bits Toggling at f ₁ =2.5 MHz, CE=GND, V _{IN} =3.4V or V _{IN} =GND | 3.9 | 12.2 ^[11] | mA |

Notes:

8. Per TTL driven input (V_{IN}=3.4V); all other inputs at V_{CC} or GND.

9. This parameter is not directly testable, but is derived for use in Total Power Supply calculations.

10. I_{CC} = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}
 I_C = I_{CC} + ΔI_{CC}D_HN_T + I_{CCD}(f₀/2 + f₁N₁)
 I_{CC} = Quiescent Current with CMOS input levels
 ΔI_{CC} = Power Supply Current for a TTL HIGH input (V_{IN}=3.4V)
 D_H = Duty Cycle for TTL inputs HIGH

N_T = Number of TTL inputs at D_H

I_{CCD} = Dynamic Current caused by an input transition pair (HLH or LHL)

f₀ = Clock frequency for registered devices, otherwise zero

f₁ = Input signal frequency

N₁ = Number of inputs changing at f₁

All currents are in milliamps and all frequencies are in megahertz.

11. Values for these conditions are examples of the I_{CC} formula. These limits are guaranteed but not tested.

Switching Characteristics Over the Operating Range^[12]

| Parameter | Description | FCT377T | | | | FCT377AT | | | | Unit | Fig. No. ^[14] |
|--------------------------------------|-----------------------------------------------------|----------------------|------|----------------------|------|----------------------|------|----------------------|------|------|--------------------------|
| | | Military | | Commercial | | Military | | Commercial | | | |
| | | Min. ^[13] | Max. | Min. ^[13] | Max. | Min. ^[13] | Max. | Min. ^[13] | Max. | | |
| t _{PLH} t _{PHL} | Propagation Delay Clock to Output | 2.0 | 15.0 | 2.0 | 13.0 | 2.0 | 8.3 | 2.0 | 7.2 | ns | 1, 5 |
| t _S | Set-Up Time HIGH or LOW Data to CP | 3.0 | | 2.0 | | 2.0 | | 2.0 | | ns | 4 |
| t _H | Hold Time HIGH or LOW Data to CP | 2.5 | | 1.5 | | 1.5 | | 1.5 | | ns | 4 |
| t _w | Set-Up Time HIGH or LOW CE to CP | 4.0 | | 3.5 | | 3.5 | | 3.5 | | ns | 4 |
| t _w | Set-Up Time HIGH or LOW CE to CP | 1.5 | | 1.5 | | 1.5 | | 1.5 | | ns | 4 |
| t _w | Clock Pulse Width ^[15] HIGH or LOW | 7.0 | | 6.0 | | 7.0 | | 6.0 | | ns | 6 |

| Parameter | Description | FCT377CT | | | | Unit | Fig. No. ^[14] |
|--------------------------------------|-----------------------------------------------|----------------------|------|----------------------|------|------|--------------------------|
| | | Military | | Commercial | | | |
| | | Min. ^[13] | Max. | Min. ^[13] | Max. | | |
| t _{PLH} t _{PHL} | Propagation Delay Clock to Output | 2.0 | 5.5 | 2.0 | 5.2 | ns | 1, 5 |
| t _S | Set-Up Time, HIGH or LOW, Data to CP | 2.0 | | 2.0 | | ns | 4 |
| t _H | Hold Time, HIGH or LOW, Data to CP | 1.5 | | 1.5 | | ns | 4 |
| t _w | Set-Up Time, HIGH or LOW, CE to CP | 3.5 | | 3.5 | | ns | 4 |
| t _w | Set-Up Time HIGH or LOW, CE to CP | 1.5 | | 1.5 | | ns | 4 |
| t _w | Clock Pulse Width ^[15] HIGH or LOW | 7.0 | | 6.0 | | ns | 6 |

Notes:

12. AC Characteristics guaranteed with C_L = 50 pF as shown in Figure 1 of the "Parameter Measurement Information" in the General Information Section.
13. Minimum limits are guaranteed but not tested on Propagation Delays.
14. See "Parameter Measurement Information" in the General Information Section.
15. With one data channel toggling, t_w(L) = t_w(H) = 4.0 ns and t_r = t_f = 1.0 ns.



Ordering Information—FCT377T

| Speed (ns) | Ordering Code | Package Name | Package Type | Operating Range |
|------------|-----------------|--------------|-------------------------------------|-----------------|
| 5.2 | CY74FCT377CTPC | P5 | 20-Lead (300-Mil) Molded DIP | Commercial |
| | CY74FCT377CTQC | Q5 | 20-Lead (150-Mil) QSOP | |
| | CY74FCT377CTSOC | S5 | 20-Lead (300-Mil) Molded SOIC | |
| 5.5 | CY54FCT377CTDMB | D6 | 20-Lead (300-Mil) CerDIP | Military |
| | CY54FCT377CTLMB | L61 | 20-Pin Square Leadless Chip Carrier | |
| 7.2 | CY74FCT377ATPC | P5 | 20-Lead (300-Mil) Molded DIP | Commercial |
| | CY74FCT377ATQC | Q5 | 20-Lead (150-Mil) QSOP | |
| | CY74FCT377ATSOC | S5 | 20-Lead (300-Mil) Molded SOIC | |
| 8.3 | CY54FCT377ATDMB | D6 | 20-Lead (300-Mil) CerDIP | Military |
| | CY54FCT377ATLMB | L61 | 20-Pin Square Leadless Chip Carrier | |
| 13.0 | CY74FCT377TPC | P5 | 20-Lead (300-Mil) Molded DIP | Commercial |
| | CY74FCT377TQC | Q5 | 20-Lead (150-Mil) QSOP | |
| | CY74FCT377TSOC | S5 | 20-Lead (300-Mil) Molded SOIC | |
| 15.0 | CY54FCT377TDMB | D6 | 20-Lead (300-Mil) CerDIP | Military |
| | CY54FCT377TLMB | L61 | 20-Pin Square Leadless Chip Carrier | |

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